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BE SEMICONDUCTOR INDUSTRIES NV Form 6-K November 22, 2006

UNITED STATES SECURITIES AND EXCHANGE COMMISSION WASHINGTON, D.C. 20549

FORM 6-K REPORT OF FOREIGN PRIVATE ISSUER PURSUANT TO RULE 13a-16 OR 15d-16 OF THE SECURITIES EXCHANGE ACT OF 1934

For The Month of November, 2006 Commission File Number 000-27298

BE Semiconductor Industries N.V.

(Translation of Registrant s Name Into English)

Marconilaan 4 5151 DR Drunen

The Netherlands

(Address of Principle Executive Offices)

Indicate by check mark whether the registrant files or will file annual reports under cover of Form 20-F or Form 40-F.

Form 20-F b Form 40-F o

Indicate by check mark if the registrant is submitting the Form 6-K in paper as permitted by Regulation S-T Rule 101(b)(1). o

Indicate by check mark if the registrant is submitting the Form 6-K in paper as permitted by Regulation S-T Rule 101(b)(7). o

Indicate by check mark whether the registrant by furnishing the information contained in this Form is also thereby furnishing the information to the Commission pursuant to Rule 12g3-2(b) under the Securities Exchange Act of 1934.

Yes o No b

(If Yes is marked, indicate below the file number assigned to the registrant in connection with Rule 12g3-2(b): 82-______.)

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BE Semiconductor Industries N.V. (the Company) is furnishing a press release dated October 31, 2006 that announced financial results for the third quarter of 2006. A copy of the press release is attached hereto as Exhibit 99.1. Exhibits

99.1 Press Release dated October 31, 2006

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Pursuant to the requirements of the Securities Exchange Act of 1934, the registrant has duly caused this report to be signed on its behalf by the undersigned, thereunto duly authorized.

BE SEMICONDUCTOR INDUSTRIES N.V.

By: /s/ Richard W. Blickman

Name: Richard W. Blickman

Title: President and Chief Executive Officer

Date: November 2, 2006

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